

<b>Notice of References Cited</b>	Application/Control No. 10/553,860		Applicant(s)/Patent Under Reexamination NANAI ET AL.	
	Examiner DAVID GOODWIN		Art Unit 2818	Page 1 of 1

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*	C	US-2006/0006377	01-2006	Golovchenko et al.	257/039
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**NON-PATENT DOCUMENTS**

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